

AUIRFS4310 AUIRFSL4310

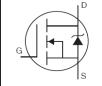
HEXFET[®] Power MOSFET

Features

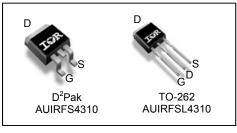
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET[®] Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications



V _{DSS}	100V
R _{DS(on)} typ.	5.6mΩ
max.	7.0mΩ
D (Silicon Limited)	130A ①
D (Package Limited)	75A



G	D	S	
Gate	Drain	Source	

Bees nort number	Dookogo Tupo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Nulliber
AUIRFSL4310	TO-262	Tube	50	AUIRFSL4310
	D ² -Pak	Tube	50	AUIRFS4310
AUIRFS4310	D -Pak	Tape and Reel Left	800	AUIRFS4310TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	130①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	92①	•
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	75	A
I _{DM}	Pulsed Drain Current @	550	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 3	980	mJ
I _{AR}	Avalanche Current ②	See Fig.14,15, 22a, 22b	A
E _{AR}	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ④	14	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol Parameter		Тур.	Max.	Units
R _{θJC}	Junction-to-Case		0.50	°C 111
R _{0JA}	Junction-to-Ambient (PCB Mount), D ² Pak®		40	°C/W

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at <u>www.infineon.com</u>

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.064		V/°C	Reference to 25°C, I _D = 1mA ②
R _{DS(on)}	Static Drain-to-Source On-Resistance		5.6	7.0	mΩ	V _{GS} = 10V, I _D = 75A ⑤
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Trans conductance	160			S	V _{DS} = 50V, I _D = 75A
R _G	Gate Resistance		1.4		Ω	f = 1.0MHz, open drain
	Drain to Course Lookana Current			20		V _{DS} = 100V, V _{GS} = 0V
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100		V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

		-	-			
Diode Char	acteristics					
Coss eff.(TR)	Effective Output Capacitance (Time Related)		720.1			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		650			V_{GS} = 0V, V_{DS} = 0V to 80V \odot
C _{rss}	Reverse Transfer Capacitance		280		pF	<i>f</i> = 1.0MHz, See Fig. 5
C _{oss}	Output Capacitance		540			V _{DS} = 50V
C _{iss}	Input Capacitance		7670			$V_{GS} = 0V$
t _f	Fall Time		78			V _{GS} = 10V⑤
t _{d(off)}	Turn-Off Delay Time		68		ns	R _G = 2.6Ω
t _r	Rise Time		110			I _D = 75A
t _{d(on)}	Turn-On Delay Time		26			V _{DD} = 65V
Q _{gd}	Gate-to-Drain Charge		62			V _{GS} = 10V⑤
Q _{gs}	Gate-to-Source Charge		46		nC	V _{DS} = 80V
Qq	Total Gate Charge		170	250		I _D = 75A

	Parameter	Min.	Тур.	Max.	Units	Conditions									
1	Continuous Source Current			130①		MOSFET symbol									
l _S	(Body Diode)			1300	А	showing the									
1	Pulsed Source Current											550		A	integral reverse
I _{SM}	(Body Diode) ②			550		p-n junction diode.									
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C,I _S = 75A,V _{GS} = 0V ⑤									
4			45	68	-	$T_{J} = 25^{\circ}C$ $V_{DD} = 85V$									
t _{rr}	Reverse Recovery Time		55	83	ns	<u>T_J = 125°C</u> I _F = 75A,									
0	Bayaraa Baaayary Charga		82	120	nC	<u>T_J = 25°C</u> di/dt = 100A/µs ⑤									
Q _{rr}	Reverse Recovery Charge		120	180		<u>T」= 125°C</u>									
I _{RRM}	Reverse Recovery Current		3.3		Α	T _J = 25°C									
t _{on}	Forward Turn-On Time	Intrinsic	turn-on	i time is	negligil	ble (turn-on is dominated by $L_{S}+L_{D}$)									

Notes:

- $\ensuremath{\mathbb{Q}}$ Repetitive rating; pulse width limited by max. junction temperature.
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 0.35mH, R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V. Part not recommended for use above this value.
- ④ $I_{SD} \le 75A$, di/dt $\le 550A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J \le 175^{\circ}C$.
- S Pulse width \leq 400µs; duty cycle \leq 2%.
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- ⑦ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 75A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.



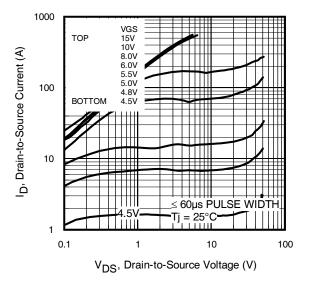


Fig. 1 Typical Output Characteristics

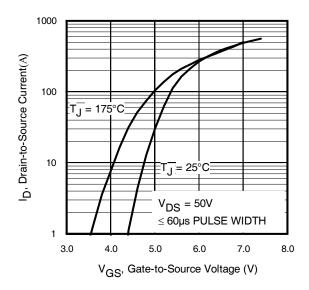


Fig. 3 Typical Transfer Characteristics

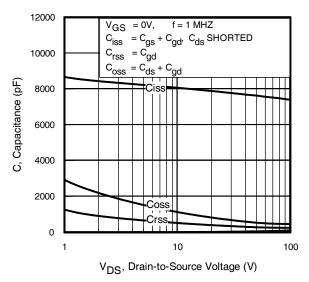


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

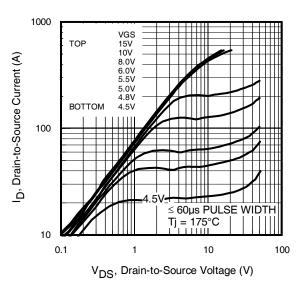


Fig. 2 Typical Output Characteristics

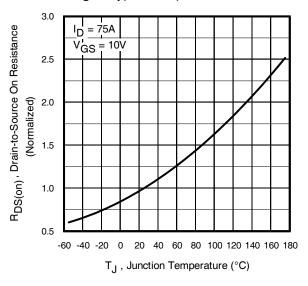


Fig. 4 Normalized On-Resistance vs. Temperature

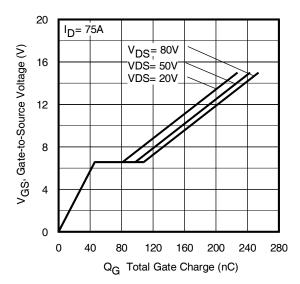
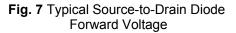
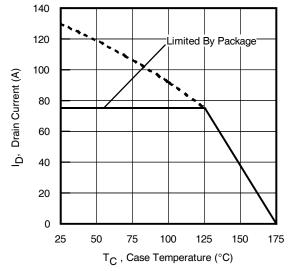


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



(P) = 100.0 $(T_{J} = 175^{\circ}C$ 100.0 $(T_{J} = 175^{\circ}C$ 10.0 $(T_{J} = 25^{\circ}C$ $(T_{J} = 25^{\circ}C$





Fg 9. Maximum Drain Current vs. Case Temperature

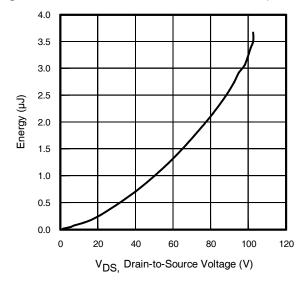


Fig 11. Typical Coss Stored Energy

AUIRFS/SL4310

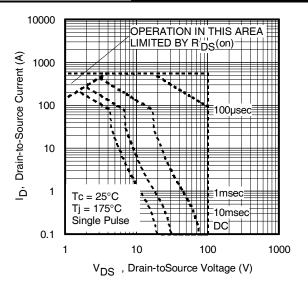


Fig 8. Maximum Safe Operating Area

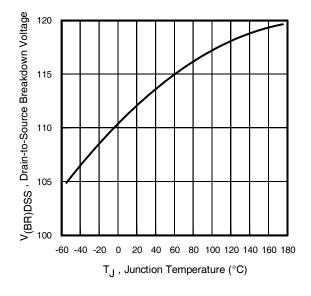


Fig 10. Drain-to-Source Breakdown Voltage

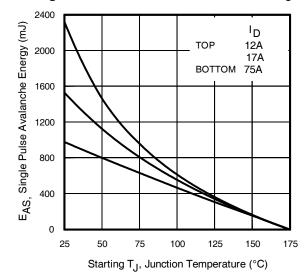
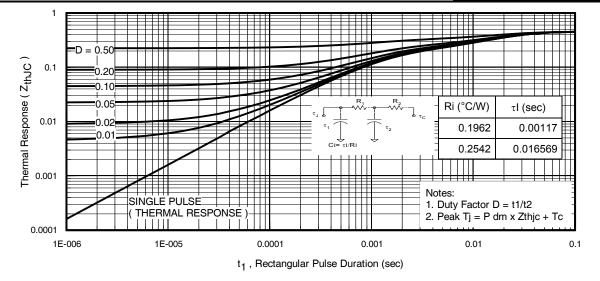
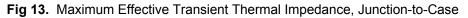


Fig 12. Maximum Avalanche Energy vs. Drain Current







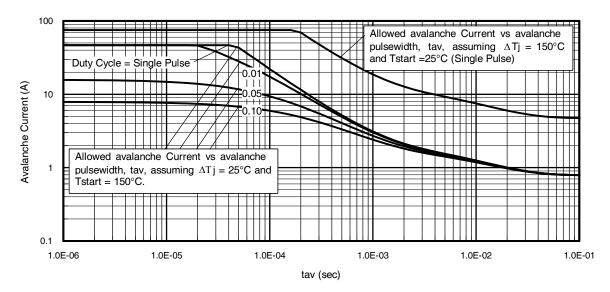
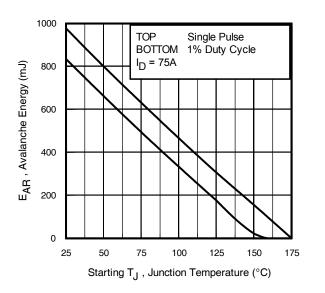


Fig 14. Avalanche Current vs. Pulse width



Notes on Repetitive Avalanche Curves , Figures 14, 15:

- (For further info, see AN-1005 at www.infineon.com)
 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 13, 14).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $tav \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \mathsf{P}_{\mathsf{D}\;(\mathsf{ave})} &= 1/2\;(\;1.3\!\cdot\!\mathsf{BV}\!\cdot\!\mathsf{I}_{\mathsf{av}}) = \Delta\mathsf{T}/\;\mathsf{Z}_{\mathsf{thJC}}\\ \mathsf{I}_{\mathsf{av}} &= 2\Delta\mathsf{T}/\;[1.3\!\cdot\!\mathsf{BV}\!\cdot\!\mathsf{Z}_{\mathsf{th}}]\\ \mathsf{E}_{\mathsf{AS}\;(\mathsf{AR})} &= \mathsf{P}_{\mathsf{D}\;(\mathsf{ave})}{\cdot}\mathsf{t}_{\mathsf{av}} \end{split}$$

Fig 15. Maximum Avalanche Energy vs. Temperature



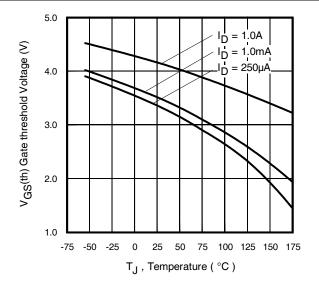
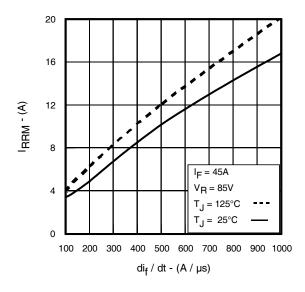
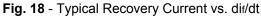


Fig 16. Threshold Voltage vs. Temperature





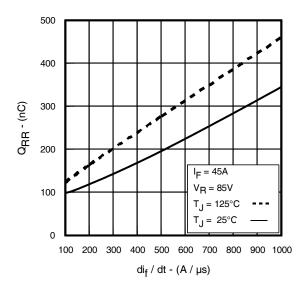


Fig. 20 - Typical Stored Charge vs. dif/dt

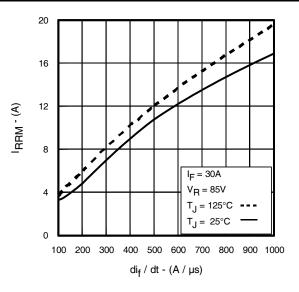


Fig. 17 - Typical Recovery Current vs. dif/dt

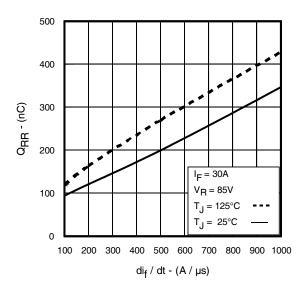
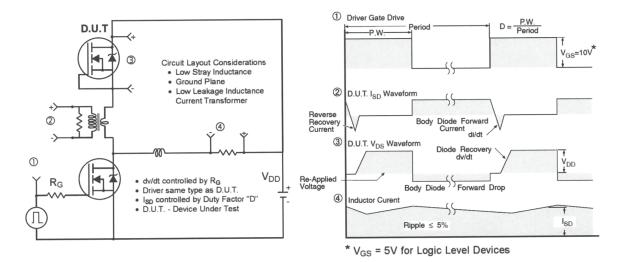
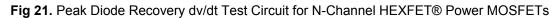


Fig. 19 - Typical Stored Charge vs. dif/dt







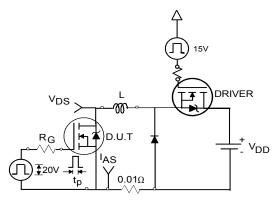


Fig 22a. Unclamped Inductive Test Circuit

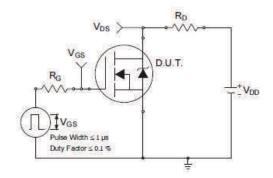


Fig 23a. Switching Time Test Circuit

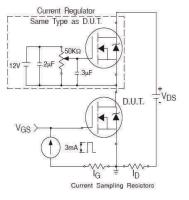


Fig 24a. Gate Charge Test Circuit

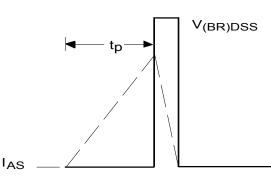
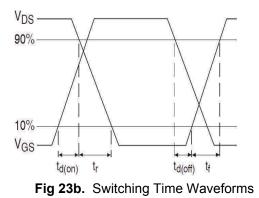
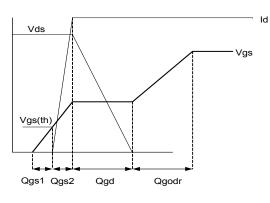
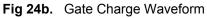


Fig 22b. Unclamped Inductive Waveforms

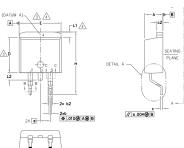




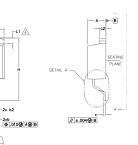




D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



AD TIF





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

PLATING BASE META (c) C, b2) - C, b2 SCETION B-B & C-C SCALE: NONE
ROTATED 90' CW SCALE 8:1

S Y		DIMEN	SIONS		N
M B	MILLIM	eters	INC	HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	L S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	_	4
Е	9.65	10.67	.380	.420	3,4
Ε1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
∟1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

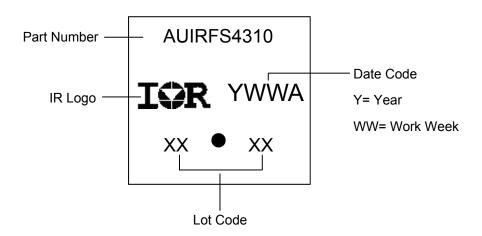
HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

> IGBTS, COPACK 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

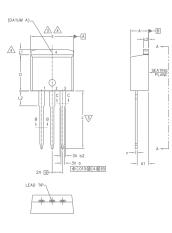
D²Pak (TO-263AB) Part Marking Information

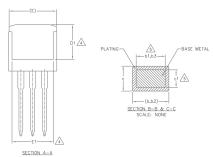


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



TO-262 Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED C.127 [.OGS"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs.	CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

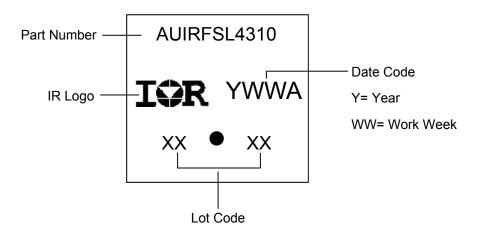
HEXFET DIODES

- 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 1.- GATE
- 2.- DRAIN 3.- SOURCE 2, 4.- CATHODE 3.- ANODE
- 4.- DRAIN



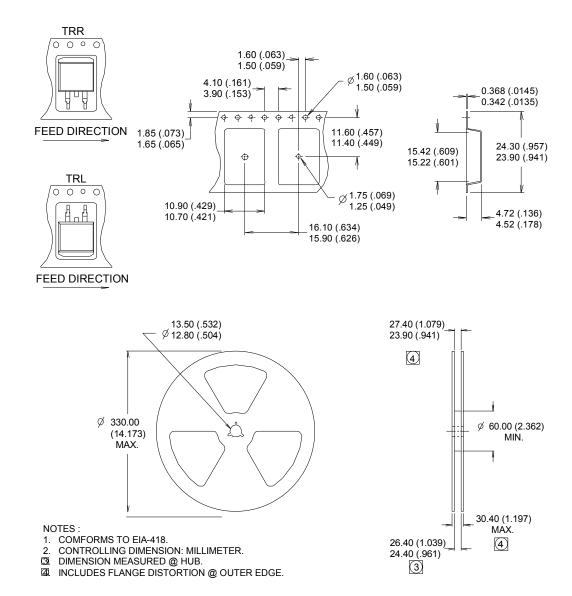
Y M		DIMENSIONS					
B	MILLIM	ETERS	INC	HES	N O T E S		
L	MIN.	MAX.	MIN.	MAX.	S		
Α	4.06	4.83	.160	.190			
A1	2.03	3.02	.080	.119			
b	0.51	0.99	.020	.039			
b1	0.51	0.89	.020	.035	5		
b2	1.14	1.78	.045	.070			
b3	1.14	1.73	.045	.068	5		
С	0.38	0.74	.015	.029			
c1	0.38	0.58	.015	.023	5		
c2	1.14	1.65	.045	.065			
D	8.38	9.65	.330	.380	3		
D1	6.86	-	.270	-	4		
E	9.65	10.67	.380	.420	3,4		
E1	6.22	-	.245		4		
е	2.54	BSC	.100 BSC				
L	13.46	14.10	.530	.555			
L1	_	1.65	-	.065	4		
L2	3.56	3.71	.140	.146			

TO-262 Part Marking Information



Note: For the most current drawing please refer to IR website at <u>http://www.irf.com/package/</u>

D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Înfineon



Qualification Information

		Automotive		
		(per AEC-Q101)		
		Comments: This part number(s) passed Automotive qualification. Infineon's		
		Industrial and Consumer qualification level is granted by extension of the higher		
		Automotive level.		
Moisture Sensitivity Level		D ² -Pak	MSL1	
		TO-262		
ESD	Machine Model	Class M4 (+/- 425V) [†]		
		AEC-Q101-002		
	Human Body Model	Class H2 (+/- 4000V) [†]		
		AEC-Q101-001		
	Charged Device Model	Class C4 (+/- 1000V) [†]		
		AEC-Q101-005		
RoHS Compliant		Yes		

† Highest passing voltage.

Revision History

Date	Comments
10/27/2015	Updated datasheet with corporate template
10/2/12013	Corrected ordering table on page 1.

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